

2/4 Outputs Ultra-Low Additive Jitter PCIe 1/2/3/4/5/6 Clock Buffer

Features

- Two (SY75602A/02B/603A/03B) and Four (SY75604A/04B) PCIe 1.0, 2.0, 3.0, 4.0, 5.0, and 6.0 Compliant Outputs.
- Ultra-Low Additive Jitter 10 fs (PCIe Gen5) and 6 fs (PCIe Gen6)
- Supports Frequencies of up to 250 MHz
- · Transparent for Spread Spectrum
- Supports 1.8V ±10%, 2.5V ±10%, and 3.3V ±10% Power Supplies
- Outputs Low Power HCSL with Embedded 85Ω (SY75602A/03A/04A) and 100Ω (SY75602B/03B/04B) Termination Resistors
- Individual Glitch Free Output Enable (OExb) Control Pins on SY75603/604
- Accepts DC-Coupled HCSL Input Signal and AC-Coupled PECL, LVDS, and CML
- Extended Temperature Range: –40°C to +105°C
- 1.4 mm x 1.6 mm VDFN (SY75602A/02B) and 3 mm x 3 mm VQFN (SY75603A/03B/604A/04B) Package

Applications

- PCIe Graphics Cards
- · PCIe Based SSD drives
- · Laptops and Desktop Computers
- Servers

General Description

The SY75602A/02B/03A/03B/04A/04B are industry leading PCIe clock buffers with ultra-low additive jitter:

- 6 fs (PCle 6.0)
- 10 fs (PCle 5.0)
- 20 fs (PCIe 3.0/4.0)
- 52 fs in 12 kHz to 20 MHz band

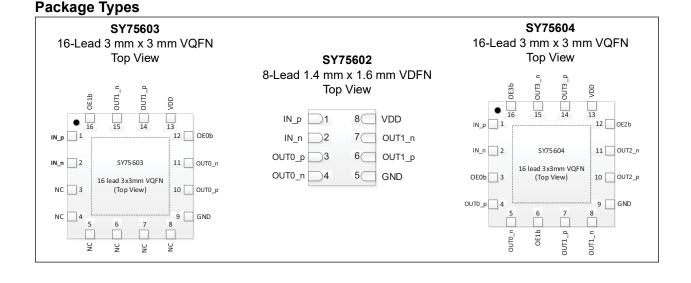
They can be used in all PCIe 1/2/3/4/5/6 common clock and SRIS applications.

SY75602A/02B are the industry's smallest (1.4 mm x 1.6 mm VDFN) two output PCIe clock buffers.

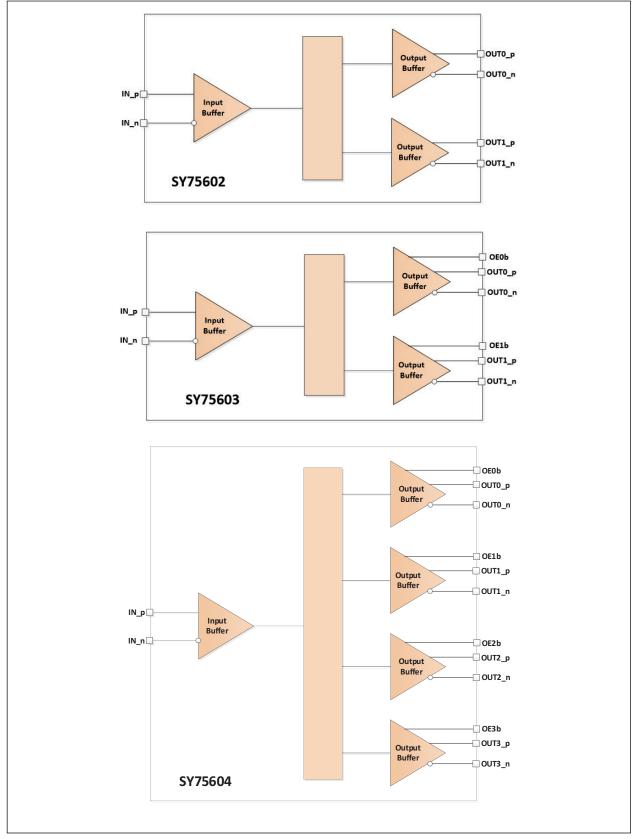
SY75603A/03B and SY75604A/04B are two and four output PCIe clock buffers with glitch free per-output enable/disable control hardware pins. Both devices are packaged in 3 mm x 3 mm VQFN.

The devices have embedded low-dropout regulators (LDO) for superior power noise supply rejection. They support 1.8V, 2.5V, and 3.3V supplies with tolerance of $\pm 10\%$ which exceeds $\pm 9\%$ required by PCIe Card Electro Mechanical Specification.

All six parts have extended temperature range: -40° C to $+105^{\circ}$ C.



Functional Block Diagrams



1.0 ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings †

Supply Voltage (V _{DD})	–0.5V to +4.6V
Input Voltage (V _{IN})	
Input ESD Protection (HBM)	

Operating Ratings ‡

1.8V Operating Voltage (V _{DD})	+1.62V to +1.98V
2.5V Operating Voltage (V _{DD})	
3.3V Operating Voltage (V _{DD})	

† Notice: Permanent device damage may occur if absolute maximum ratings are exceeded. This is a stress rating only and functional operation is not implied at conditions other than those detailed in the operational sections of this data sheet. Exposure to absolute maximum ratings conditions may affect device reliability.

‡ Notice: The data sheet limits are not ensured if the device is operated beyond the recommended operating conditions.

ELECTRICAL CHARACTERISTICS

Electrical Characteristics: V_{DD} = 3.3V ±10%, 2.5V±10%; 1.8V±10%; T_A = -40°C to +105°C, unless noted.

Parameter	Symbol	Min.	Тур.	Max.	Units	Conditions
Current Consumption						·
Core Device Current	1	_	9	13	mA	SY75602, Output current excluded (no load)
Core Device Current	I _{DD}	_	9	13	mA	SY75603/04, all outputs disabled
Current dissipation per each LP-HCSL output (100Ω)	I _{OUT_HCSL_100Ω}	_	3.5	3.9	mA	Note 1
Current dissipation per each LP-HCSL output (85Ω)	$I_{OUT_HCSL_85\Omega}$	—	4.0	4.4	mA	Note 1
Power Supply Noise Reje	ction Ratio Ch	naracteris	tics			
Power Supply Noise Rejection Ratio	PSNRR _{HSCL}	_	70	_	dB	100 mV _{PP} , 100 kHz noise injected to V _{DD} . Clock Frequency 100 MHz, V _{DD} = $3.3V$
Input Characteristics						
Input Slew Rate	SR _{IN}	0.6	_	_	V/ns	—
Differential Input High Voltage	V _{IH}	0.15	_	_	V	_
Differential Input Low Voltage	V _{IL}		_	-0.15	V	—
Input Voltage Swing	V _{SWING}	0.15	_	—	V _{DIFF}	—
Absolute Crossing Point Voltage	V _{CROSS}	0.25	_	0.55	V	—
Variation of V _{CROSS} Over All Edges	V _{CROSS_DELTA}	_		0.14	V	—
Voltage High for Output Enable	V _{IH_OE}	0.7* V _{DD}	_	_	V	SY75603/4 only
Voltage Low for Output Enable	V _{IL_OE}	—		0.3* V _{DD}	V	SY75603/4 only
Input Leakage Current	I _{IL_IN}	-5	_	5	μA	V _{IN} = V _{IN(MAX)} , V _{IN} = GND
Input Capacitance	C _{IN}		_	5	pF	—

ELECTRICAL CHARACTERISTICS

Electrical Characteristics: V_{DD} = 3.3V ±10%, 2.5V±10%; 1.8V±10%; T_A = -40°C to +105°C, unless noted.

Parameter	Symbol	Min.	Тур.	Max.	Units	Conditions
Input Leakage Current for OExb Inputs (Includes Current due to Pull-Down Resistors)	I _{IL_OE}	-5	_	50	μΑ	V _{IN} = V _{DD} , V _{IN} = GND SY75603/4 only
Single Ended Input Common Mode Voltage (IN_p) (HCSL Common Mode)	V _{SIC}	0.25	_	0.55	V	_
Single Ended Input Voltage Swing for IN_p	V _{SID}	0.3	_	1.45	V	_
Maximum Input Voltage	V _{IN(MAX)}	_	—	1.15	V	—
Minimum Input Voltage	V _{IN(MIN)}	-0.3	_		V	—
Input Frequency (Differential)	f _{IN}	0	_	250	MHz	—
Input Frequency (Single Ended)	f _{IN_SE}	0	_	250	MHz	_
Input Duty Cycle	DC	35	_	65	%	—

Note 1: Tested with 100 MHz clock with outputs driving 5" long trace terminated with 2 pF capacitors to ground.

2: Output Enable control pins are synchronous with the input clock and it takes four rising edges before outputs get enabled and five rising edges before outputs get disabled. Hence the minimum input frequency is greater than 0 Hz. Once the outputs are enabled the input clock frequency can be reduced to 0 Hz.

OUTPUT ELECTRICAL CHARACTERISTICS

Electrical Characteristics: V_{DD} = 3.3V ±10%, 2.5V±10%; 1.8V±10%; T_A = -40°C to +105°C, C_{LOAD} = 2 pF unless noted.

Parameter	Symbol	Min.	Тур.	Max.	Units	Conditions
Rising Edge Rate	—	1	2.5	4	V/ns	Note 2, Note 3
Falling Edge Rate	—	1	2.5	4	V/ns	Note 2, Note 3
Differential Output High Voltage	V _{OH}	0.6	—	0.9	V	Note 2
Differential Output Low Voltage	V _{OL}	-0.9	—	-0.6	V	Note 2
Absolute Crossing Voltage	V _{CROSS}	0.25	_	0.55	V	Note 1, Note 4, Note 5
Variation of V _{CROSS} Over All Rising Clock Edges	V _{CROSS_DELTA}	_	_	0.14	V	Note 1, Note 4, Note 8
Ring Back Voltage Margin	V _{RB}	-0.1	_	0.1	V	Note 2, Note 10
Time Before V _{RB} is Allowed	t _{STABLE}	500	—		ps	Note 2, Note 10
Cycle-to-Cycle Additive Jitter	t _{CCJITTER}	_	6.5	8.1	ps	Note 2
Absolute Maximum Output Voltage	V _{MAX}	—	—	1.15	V	Note 1, Note 6
Absolute Minimum Output Voltage	V _{MIN}	-0.3	—	_	V	Note 1, Note 7
Output Duty Cycle	V _{DC}	48	50	52	%	When input has 50% duty cycle and V _{IN} ≥ 200 mV, Note 2
Rising to Falling Edge Matching	Rise-Fall Matching	_	-	20	%	Note 1, Note 11
Clock Source DC Impedance (OUTx_p) for part with 85Ω embedded differential series resistance (parts with suffix "A")	Z _{C-DC_OUT_p}	34	_	51	Ω	Note 1, Note 9

OUTPUT ELECTRICAL CHARACTERISTICS (CONTINUED)

Electrical Characteristics: V_{DD} = 3.3V ±10%, 2.5V±10%; 1.8V±10%; T_A = -40°C to +105°C, C_{LOAD} = 2 pF unless noted.

Parameter	Symbol	Min.	Тур.	Max.	Units	Conditions
Clock Source DC Impedance (OUTx_n) for part with 85Ω embedded differential series resistance (parts with suffix "A")	Z _{C-DC_OUT_n}	34	_	51	Ω	Note 1, Note 9
Clock Source DC Impedance (OUTx_p) for part with 100Ω embedded differential series resistance (parts with suffix "B")	Z _{C-DC_OUT_P}	40	_	60	Ω	Note 1, Note 9
Clock Source DC Impedance (OUTx_n) for part with 100Ω embedded differential series resistance (parts with suffix "B")	Z _{C-DC_OUT_n}	40	_	60	Ω	Note 1, Note 9
Output Frequency	F _{MAX}	0	-	250	MHz	—
Output to Output Skew	t _{oosk}	—	-	30	ps	—
Device to Device Output Skew	t _{POOSK}	_	_	50	ps	—
Input to Output Delay	t _{IOD}	0.9	1.2	1.5	ns	—
Output Enable Time	t _{EN}	_	—	3.5	cycles	Note 12
Output Disable Time	t _{DIS}	_	_	4.5	cycles	Note 12

Note 1: Measurement taken from single ended waveform.

- 2: Measurement taken from differential waveform.
- 3: Measured from –150 mV to +150 mV on the differential waveform (derived from OUTx_p to OUTx_n). The signal must be monotonic through the measurement region for rise and fall time. The 300 mV measurement window is centered on the differential zero crossing. See Figure 1-5.
- 4: Measured at crossing point where the instantaneous voltage value of the rising edge of OUTx_p equals the falling edge of OUTx_n. See Figure 1-1.
- **5:** Refers to the total variation from the lowest crossing point to the highest, regardless of which edge is crossing. Refers to all crossing points for this measurement. See Figure 1-1.
- 6: Defined as the maximum instantaneous voltage including overshoot. See Figure 1-1.
- 7: Defined as the minimum instantaneous voltage including undershoot. See Figure 1-1.
- 8: Defined as the total variation of all crossing voltages of Rising OUTx_p and Falling OUTx_n. This is the maximum allowed variance in V_{CROSS} for any particular system. See Figure 1-2.
- 9: System board compliance measurements must use the test load card described in Figure 1-7. OUTx_p and OUTx_n are to be measured at the load capacitors C_{LOAD}. Single-ended probes must be used for measurements requiring single-ended measurements. Either single-ended probes with math or differential probe can be used for differential measurements.
- 10: t_{STABLE} is the time the differential clock must maintain a minimum ±150 mV differential voltage after rising/falling edges before it is allowed to droop back into the V_{RB} ±100 mV differential range. See Figure 1-6.
- 11: Matching applies to rising edge rate for OUTx_p and falling edge rate for OUTx_n. It is measured using a ±75 mV window centered on the median cross point where OUTx_p rising meets OUTx_n falling. The median cross point is used to calculate the voltage thresholds the oscilloscope is to use for the edge rate calculations. The Rise Edge Rate of OUTx_p should be compared to the Fall Edge Rate of OUTx_n; the maximum allowed difference should not exceed 20% of the slowest edge rate. See Figure 1-3.
- **12:** Output Enable control pins are synchronous with the input clock and it takes four rising edges before outputs get enabled and five rising edges before outputs get disabled. Hence the minimum input frequency is greater than 0 Hz. Once the outputs are enabled the input clock frequency can be reduced to 0 Hz.

JITTER AND PHASE NOISE

Parameter	Symbol	Min.	Тур.	Max.	Units	Conditions
Peak-to-Peak Additive Jitter	p-p A _{JRMS}	_	—	4.5	ps	Note 1, Note 2
Additive Jitter as per PCle 1.0 (1.5 MHz to 22 MHz)	t _{jPCle_1.0}		0.7	0.8	ps _{RMS}	Note 1, Note 2
Additive Jitter as per PCle 2.0 high band (1.5 MHz to 50 MHz)	t _{jPCle_2.0_high}	_	70	90	fs _{RMS}	Note 1, Note 2
Additive Jitter as per PCIe 2.0 low band (10 kHz to 1.5 MHz)	t _{jPCIe_2.0_low}		14	20	fs _{RMS}	Note 1, Note 2
Additive Jitter as per PCle 2.0 mid band (5 MHz to 16 MHz)	^t jPCIe_2.0_mid	_	55	74	fs _{RMS}	Note 1, Note 2
Additive Jitter as per PCle 3.0 (PLL_BW = 2 to 5 MHz, CDR = 10 MHz)	t _{jPCle_3.0}	_	18	22	fs _{RMS}	Note 1, Note 2
Additive Jitter as per PCle 4.0 (PLL_BW = 2 to 5 MHz, CDR = 10 MHz)	t _{jPCle_4.0}		18	22	fs _{RMS}	Note 1, Note 2
Additive Jitter as per PCle 5.0 (PLL_BW = 0.5 to 1.8 MHz, CDR for 32 GT/s CC)	t _{jPCle_5.0}	_	7	10	fs _{RMS}	Note 2, Note 3
Additive Jitter as per PCle 6.0 (PLL_BW = 0.5 to 1 MHz, CDR for 64 GT/s CC)	t _{jPCle_6.0}	_	4.5	6	fs _{RMS}	Note 2, Note 3
Additive jitter as per Intel QPI 9.6 Gbps	t _{jQPI}		35	45	fs _{RMS}	Note 1, Note 2
			51	66	fs _{RMS}	Note 1, Note 2 (100 MHz clock)
Additive RMS jitter in 1 MHz to 20 MHz band	^t j_1M_20М	_	40	54	fs _{RMS}	Note 1, Note 2 (133 MHz clock)
	# 401-0014	_	52	68	fs _{RMS}	Note 1, Note 2 (100 MHz clock)
Additive RMS jitter in 12 kHz to 20 MHz band	tj_12k_20M		44	58	fs _{RMS}	Note 1, Note 2 (133 MHz clock)
		_	-165	-163	dBc/Hz	Note 1, Note 2 (100 MHz clock)
Noise Floor	NF	_	-165	-163	dBc/Hz	Note 1, Note 2 (133 MHz clock)

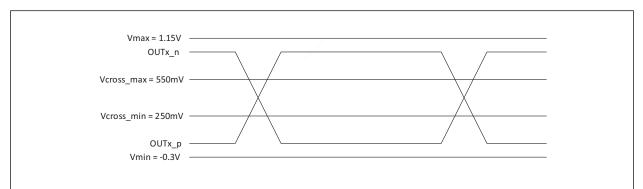
Note 1: Measured into AC test load as per Figure 1-7.

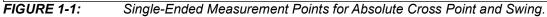
2: Measured from differential crossing point to differential crossing point.

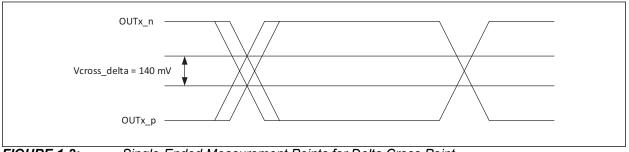
3: Measured with 50Ω termination in instrument without a test load.

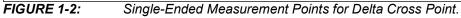
TEMPERATURE SPECIFICATIONS

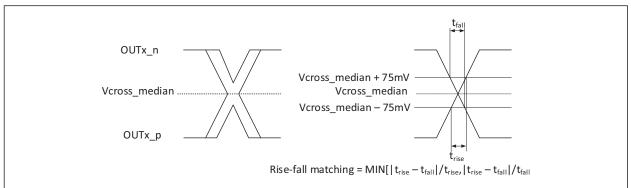
Parameters	Symbol	Min.	Тур.		Max.	Unit	Condition
Temperature Ranges							
Ambient Operating Temperature Range	T _A	-40	_	_	+105	°C	—
Storage Temperature Range	T _S	-65		_	+150	°C	—
Package Thermal Resistances	age Thermal Resistances						
	θ _{JA}		138	35.7	_		Still air
Junction-to-Ambient Thermal Resistance		_	132	30.8	—	°C/W	1m/s airflow
		_	127	28.6	_]	2.5m/s airflow
Junction-to-Board Thermal Resistance	θ _{JB}		104	5	_	°C/W	—
Junction-to-Case Thermal Resistance	θ _{JC}		105	49.5	_	°C/W	—
Thermal Characterization, Junction- to-Top of Package	Ψ_{JT}	_	11.5	3	_	°C/W	Still air

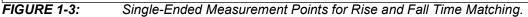












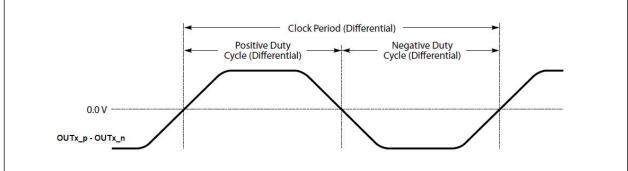


FIGURE 1-4: Differential Measurement Points for Duty Cycle and Period.

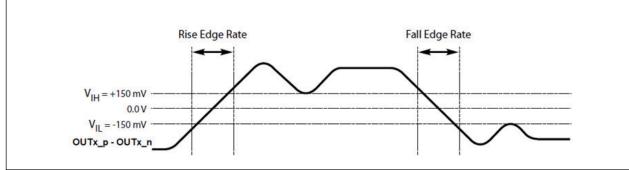
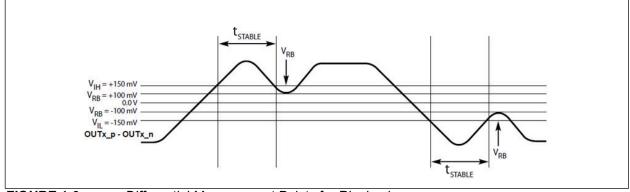
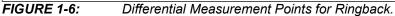


FIGURE 1-5: Differential Measurement Points for Rise and Fall Time.





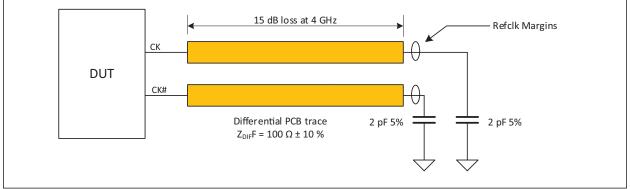


FIGURE 1-7: PCIe Test Load.

2.0 TYPICAL OPERATING CHARACTERISTICS

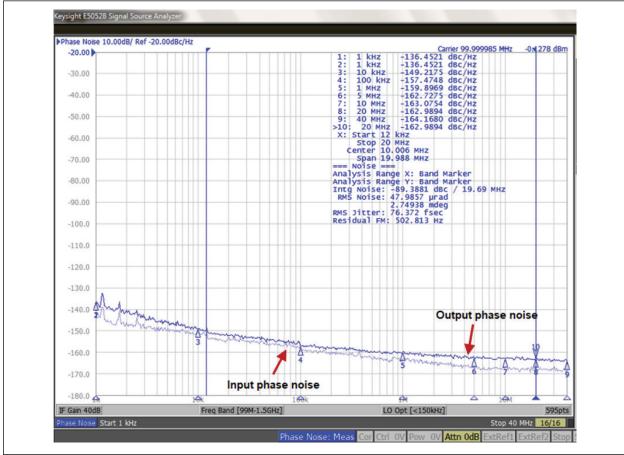


FIGURE 2-1:

Typical Expected Phase Noise.

3.0 PIN DESCRIPTIONS

All device inputs and outputs are LP-HCSL unless described otherwise. The Type column uses the following symbols:

- I: Input
- IPD: Input with 100 k $\!\Omega$ internal pull-down resistor
- O: Output
- P: Power supply

The descriptions of the pins are listed in Table 3-1 and Table 3-2.

TABLE 3-1: SY75602A/02B PIN FUNCTION TABLE

Pin Number	Pin Name	Туре	Description
Input Refere	ence		
1	IN_p		Differential/Single Ended Input Reference
			Input frequency range >0 Hz to 250 MHz.
2	IN_n	I	Note 1: >0 Hz means frequency higher than DC. On the power up, the device needs four clock cycles before the outputs get enabled. This feature filters any initial glitch or runt pulse from the clock source.
			Note 2: The differential input has hysteresis of 30 mV that prevents outputs from randomly toggling when both p and n inputs are at the same voltage level. For example, when p and n inputs are held low as in the case when the buffer is driven from an HCSL driver that is disabled.
Output Cloc	ks		
3	OUT0_p		
4	OUT0_n	ο	Ultra-Low Additive Jitter Differential Outputs 0 and 1
6	OUT1_p	0	Output frequency range >0 Hz to 250 MHz.
7	OUT1_n		
Power and C	Ground		
8	VDD	Р	Positive Supply Voltage: Connect to either 3.3V, 2.5V, or 1.8V supply.
5	GND	Р	Ground: Connect to ground.

Pin Number	Pin Name SY75604A/04B	Pin Name SY75603A/03B	Туре	Description						
Input Refer	ence			·						
1	IN_p	IN_p		Differential/Single Ended Input Reference						
2	IN_n	IN_n	I	Input frequency range >0 Hz to 250 MHz Note 1: >0 Hz means frequency higher than DC. Output Enable control pins (OExb) need four clock cycles before the corre- sponding output get enabled/disable. This feature ensures glitch free transition of the outputs.						
				Note 2: The differential input has hysteresis of 30 mV that prevents outputs from randomly toggling when both p and n inputs are at the same voltage level. For example, when p and n inputs are held low as in the case when the buffer is driven from an HCSL driver that is disabled.						
Output Cloc	ks			•						
4	OUT0_p	NC								
5	OUT0_n	NC		Ultra-Low Additive Jitter Differential Outputs 0 to 1						
7	OUT1_p	NC		(SY75603A/03B) and 0 to 3 (SY75604A/04B)						
8	OUT1_n	NC	ο	Output frequency range >0 Hz to 250 MHz						
10	OUT2_p	OUT0_p								
11	OUT2_n	OUT0_n								NC are no connect pins. They are not bonded to the die but they
14	OUT3_p	OUT1_p							should be soldered to the board for mechanical reasons.	
15	OUT3_n	OUT1_n								
Control Inp	uts									
3	OE0b	NC		Output Enable Control						
6	OE1b	NC								
12	OE2b	OE0b		When OExb is low the output x where $x = \{0,1\}$ for SY75603A/03B and $x = \{0,1,2,3\}$ for SY75604A/04B is active.						
16	IPD OExb is synchronous and it takes 3.5 clock clock to enable and 4.5 clock to disable the	IPD		OExb is synchronous and it takes 3.5 clock cycles of the input clock to enable and 4.5 clock to disable the output. OExb pins are pulled-down with 100 k Ω resistor						
				NC are no connect pins. They are not bonded to the die but they should be soldered to the board for mechanical reasons.						
Power and	Ground									
13	VDD	VDD	Ρ	Positive Supply Voltage: Connect to either 3.3V, 2.5V, or 1.8V supply.						
9 ePad	GND	GND	Ρ	Ground: Connect to ground.						

TABLE 3-2: SY75604A/04B AND SY75603A/03B PIN FUNCTION TABLE

4.0 FUNCTIONAL DESCRIPTION

The SY75602A/02B/603A/03B/604A/04B are PCle clock buffers with ultra-low additive jitter. They can be used in all PCle 1/2/3/4/5/6 common clock and SRIS applications.

SY75602A/02B are the industry's smallest (1.4 mm x 1.6 mm VDFN) two output PCIe clock buffers.

SY75603A/03B and SY75604A/04B are two and four output PCIe clock buffers with glitch free per-output enable/disable control hardware pins. Both devices are packaged in 3 mm x 3 mm VQFN.

The devices have embedded low-dropout regulators (LDO) for superior power noise supply rejection. They support 1.8V, 2.5V, and 3.3V supplies with tolerance of $\pm 10\%$ which exceeds $\pm 9\%$ required by PCIe Card Electro Mechanical Specification.

4.1 Clock Input

Please refer to the Functional Block Diagrams on how to terminate different signals fed to the input of the device.

Figure 4-1 and Figure 4-2 show how to terminate input of the device in most common cases: Low Power HCSL (LPHCSL), HCSL, and single-ended LVCMOS.

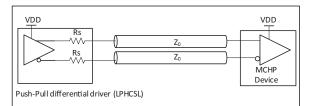
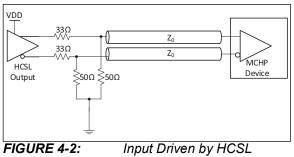


FIGURE 4-1: Input Driven by LPHCSL Driver.



Driver.

Figure 4-3 shows how to terminate a single-ended output, such as LVCMOS. This example assumes 50Ω transmission line which is the most common for single ended CMOS signaling. Ideally, resistors R1 and R2 should be 100Ω each and R₀ + R_S should be 50Ω so that the transmission line is terminated at both ends with characteristic impedance. If the driving strength of the output driver is not sufficient to drive low

impedance, the value of series resistor R_S should be increased. This will reduce the voltage swing at the input but this should be fine as long as the input voltage swing requirement is not violated (0.3V). The source resistors of R_S = 270 Ω could be used for standard LVCMOS driver. This will provide 516 mV of voltage swing for 3.3V LVCMOS driver with load current of (3.3V/2) * (1/(270 Ω + 50 Ω)) = 5.16 mA.

For optimum performance both differential input pins $(_p \text{ and }_n)$ need to be DC biased to the same voltage. Hence, the ratio R1/R2 should be equal to the ratio R3/R4.

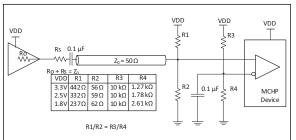


FIGURE 4-3: Input Driven from a Single-Ended CMOS Output.

The differential input has hysteresis of 30 mV that prevents outputs from randomly toggling when both p and n inputs are at the same voltage level. For example, when p and n inputs are held low as in the case when the buffer is driven from an HCSL driver that is disabled.

4.2 Clock Outputs

Differential outputs have embedded termination resistors as shown in Figure 4-4. This provides significant saving relative to traditional current based HCSL outputs which require four resistors per differential output.

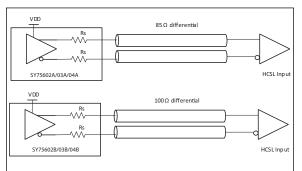


FIGURE 4-4: Terminating Differential Outputs.

Embedded termination resistors in SY75602A/603A/604A are matched for 85Ω and embedded termination resistors in SY75602B/603B/604B are matched for 100Ω differential transmission line.

4.3 Output Enable

Each output of SY75603A/03B/04A/04B has an active low Output Enable (OExb) control pin. Output Enable and Disable function is synchronous with the input clock which results in glitchless transitions as shown in Figure 4-5 and Figure 4-6. The OExb is sampled on the falling edge of the differential input (or falling edge of IN_p signal). It takes 3.5 clock cycles of the input clock to enable an output and 4.5 clock cycles to disable the output, after the change of OExb is sampled.

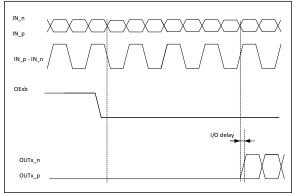


FIGURE 4-5: OExb Assertion (Output Enable) Timing Diagram.

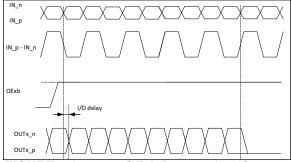
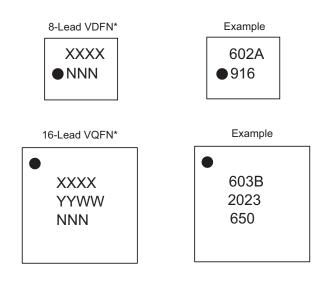


FIGURE 4-6: OExb Deassertion (Output Disable) Timing Diagram.

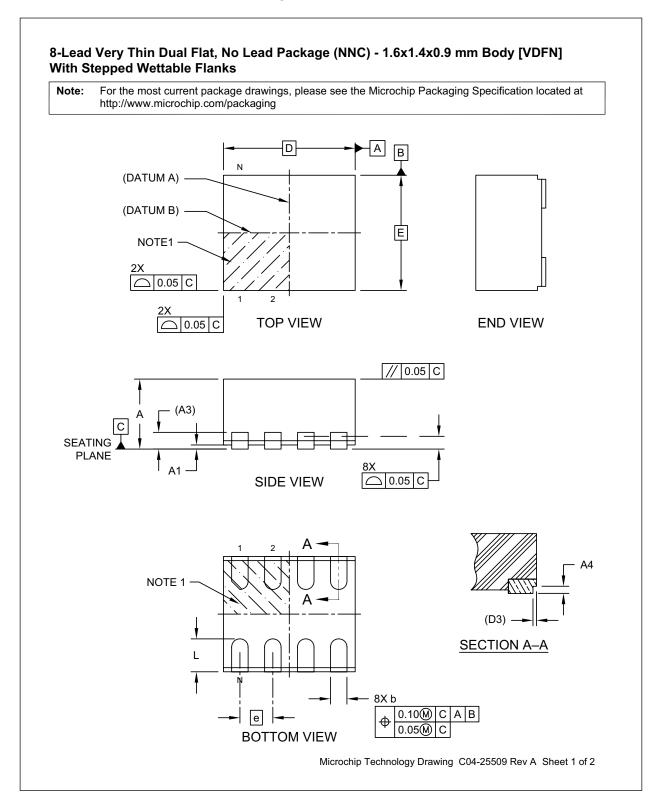
5.0 PACKAGING INFORMATION

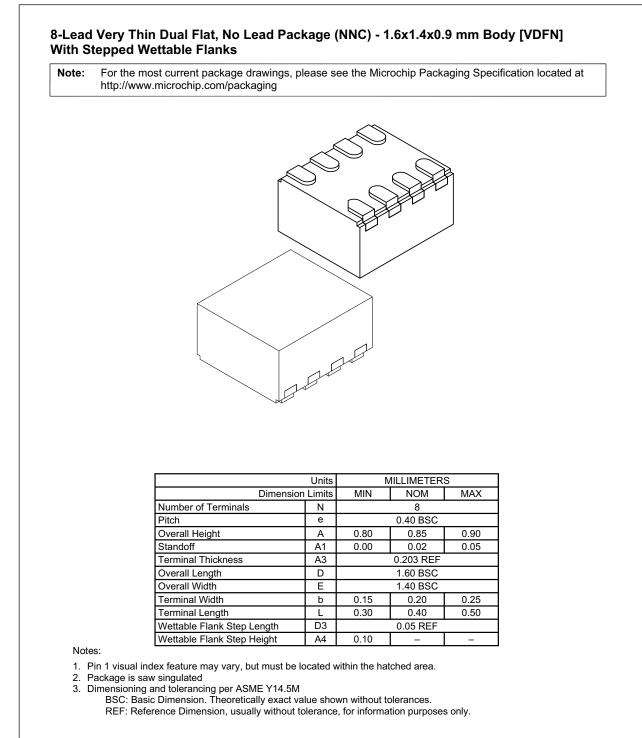
5.1 Package Marking Information



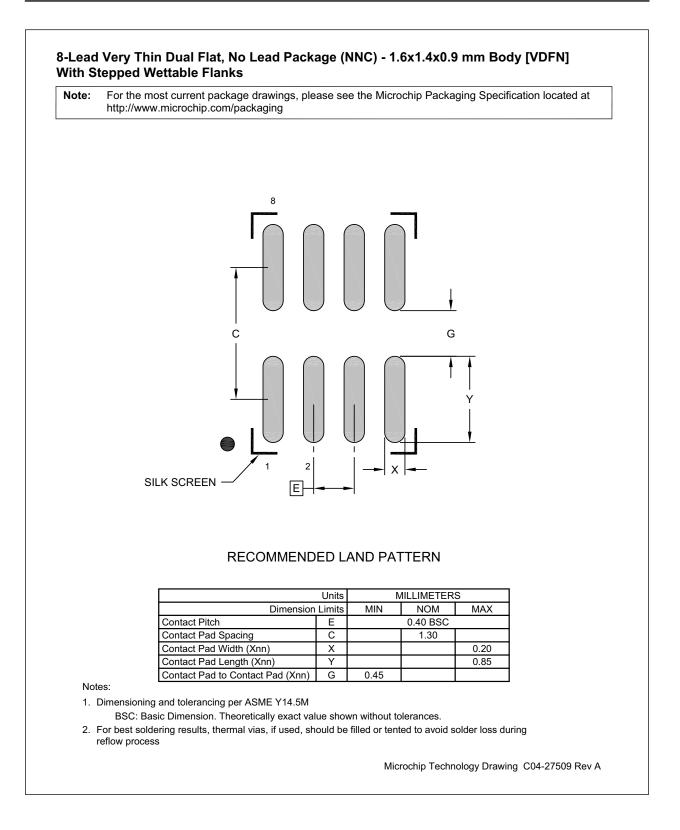
Legend:	XXX	Product	со	de c	r		ner-spe	cific	infor	mation	
	Y	Year	code	(last		digit	of	caler	ndar	year)	
	YY	Year	code	(last	2	digits	of	cale	endar	year)	
	WW	Week	code	(week	of	Janua	ry 1	is	week	'01')	
	NNN	Alphanu	Imeric			tracea	bility			code	
	(e3)	Pb-free	JED	EC [®] c	lesio	nator	for	Matte	Tin	(Sn)	
	* This package is Pb-free. The Pb-free JEDEC designate(e3)) can be found on the outer packaging for this package.										
	●, ▲, ▼ mark).	Pin one	index is	identified	by a	a dot, del	ta up, o	r delta	down (t	riangle	
	In the even be carried characters the corpor	d over to s for custo	b the n	ext line,	thu	s limiting	g the r	numbe	r of av	ailable	
	Underbar	(_) and/or	⁻ Overba	ır ([–]) syml	ool n	nay not b	e to sca	ale.			

8-Lead VDFN 1.6 mm x 1.4 mm Package Outline and Recommended Land Pattern

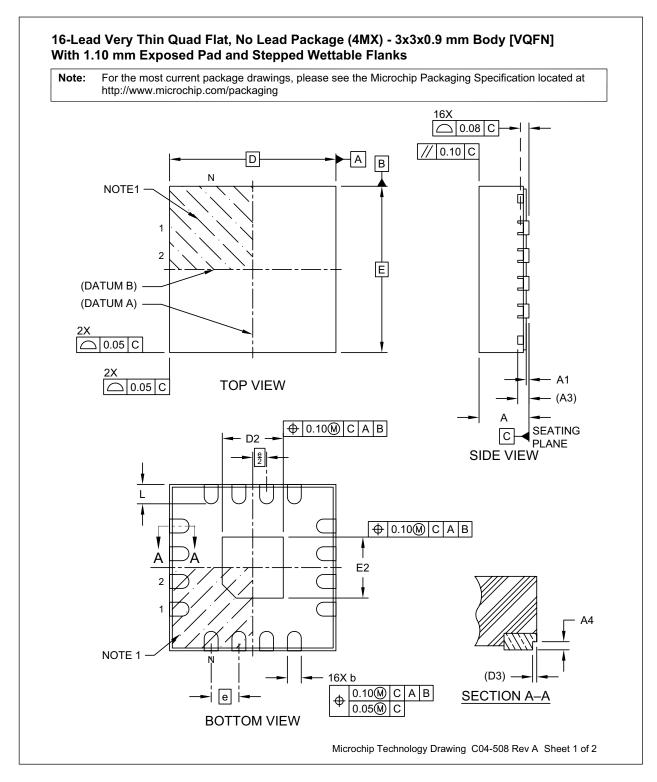


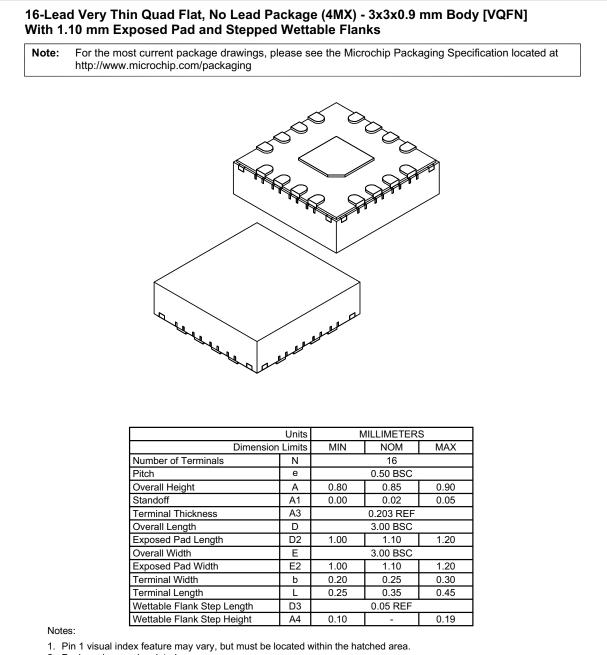


Microchip Technology Drawing C04-25509 Rev A Sheet 2 of 2



16-Lead VQFN 3.0 mm x 3.0 mm Package Outline and Recommended Land Pattern





2. Package is saw singulated

3. Dimensioning and tolerancing per ASME Y14.5M

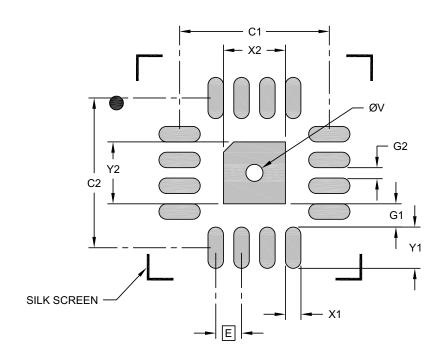
BSC: Basic Dimension. Theoretically exact value shown without tolerances.

REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing C04-508 Rev A Sheet 2 of 2

16-Lead Very Thin Quad Flat, No Lead Package (4MX) - 3x3x0.9 mm Body [VQFN] With 1.10 mm Exposed Pad and Stepped Wettable Flanks

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



RECOMMENDED LAND PATTERN

	Units	Ν	/ILLIMETER	S
Dimension	Limits	MIN	NOM	MAX
Contact Pitch	Е		0.50 BSC	
Optional Center Pad Width	X2			1.20
Optional Center Pad Length	Y2			1.20
Contact Pad Spacing	C1		2.90	
Contact Pad Spacing	C2		2.90	
Contact Pad Width (X16)	X1			0.30
Contact Pad Length (X16)	Y1			0.80
Contact Pad to Center Pad (X16)	G1	0.45		
Contact Pad to Contact Pad (X12)	G2	0.20		
Thermal Via Diameter	V		0.33	

Notes:

1. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

2. For best soldering results, thermal vias, if used, should be filled or tented to avoid solder loss during reflow process

Microchip Technology Drawing C04-2508 Rev A

APPENDIX A: REVISION HISTORY

Revision A (September 2021)

• Initial release of SY75602A/02B/603A/03B/604A/ 04B as Microchip data sheet DS20006508A.

Revision B (October 2021)

- Updated various values in the Electrical Characteristics, Output Electrical Characteristics, and Jitter and Phase Noise tables.
- Updated Note 12 in the Output Electrical Characteristics table.
- Updated Input Reference description in Table 3-1 and Table 3-2.
- Updated Control Inputs description in Table 3-2.
- Added paragraph immediately after Figure 4-3.

Revision C (July 2022)

• Added information specific to the 85Ω devices to the Current Consumption section of the Electrical Characteristics table.

Revision D (May 2023)

- Added PCIe Gen6 information to Features, General Description, and Jitter and Phase Noise.
- Added temperature range information to the Temp Spec table.

NOTES:

PRODUCT IDENTIFICATION SYSTEM

To order or obtain information, e.g., on pricing or delivery, contact your local Microchip representative or sales office.

PART NO.		xxx	[-XX]	Exa	ample	s:		
Device	SY75602A: SY75602B: SY75603A: SY75603B: SY75604A:	 1/2/3/4/5/6 85Ω Clock Buffer 2 Output Ultra-Low Additive Jitter PCIe 1/2/3/4/5/6 100Ω Clock Buffer 2 Output Ultra-Low Additive Jitter PCIe 1/2/3/4/5/6 85Ω Clock Buffer 2 Output Ultra-Low Additive Jitter PCIe 1/2/3/4/5/6 100Ω Clock Buffer 		b) TR c)	a) SY75603ATWL: b) SY75602BTWL- TR: c) SY75604ATWL- TR:		2 Output Ultra-Low Additive Jitter PCIe 1/2/3/4/5/6 85Ω Clock Buffer, 16-Lead 3 mm x 3 mm VQFN, 120/Tube 2 Output Ultra-Low Additive Jitter PCIe 1/2/3/4/5/6 100Ω Clock Buffer, 8-Lead 1.4 mm x 1.6 mm VDFN, 2,000/Reel 4 Output Ultra-Low Additive Jitter PCIe 1/2/3/4/5/6 85Ω Clock Buffer, 16-Lead 3 mm x 3 mm VQFN,	
Package:	SY75604B: TWL = TWL =	1/2/3/4/5/6 85Ω 4 Output Ultra-L 1/2/3/4/5/6 100 8-Lead 1.4 mm x	Ω Clock Buffer Low Additive Jitter PCIe		te 1:	catalog pa used for o the device Sales Off	3,300/Reel I Reel identifier only appears in the art number description. This identifier is ordering purposes and is not printed on e package. Check with your Microchip fice for package availability with the I Reel option.	
Media Type:	<blank> = TR = TR =</blank>		ad Package Option) ead Package Option)					

NOTES:

Note the following details of the code protection feature on Microchip products:

- Microchip products meet the specifications contained in their particular Microchip Data Sheet.
- Microchip believes that its family of products is secure when used in the intended manner, within operating specifications, and under normal conditions.
- Microchip values and aggressively protects its intellectual property rights. Attempts to breach the code protection features of Microchip product is strictly prohibited and may violate the Digital Millennium Copyright Act.
- Neither Microchip nor any other semiconductor manufacturer can guarantee the security of its code. Code protection does not
 mean that we are guaranteeing the product is "unbreakable" Code protection is constantly evolving. Microchip is committed to
 continuously improving the code protection features of our products.

This publication and the information herein may be used only with Microchip products, including to design, test, and integrate Microchip products with your application. Use of this information in any other manner violates these terms. Information regarding device applications is provided only for your convenience and may be superseded by updates. It is your responsibility to ensure that your application meets with your specifications. Contact your local Microchip sales office for additional support or, obtain additional support at https:// www.microchip.com/en-us/support/design-help/client-supportservices.

THIS INFORMATION IS PROVIDED BY MICROCHIP "AS IS". MICROCHIP MAKES NO REPRESENTATIONS OR WAR-RANTIES OF ANY KIND WHETHER EXPRESS OR IMPLIED, WRITTEN OR ORAL, STATUTORY OR OTHERWISE, RELATED TO THE INFORMATION INCLUDING BUT NOT LIMITED TO ANY IMPLIED WARRANTIES OF NON-INFRINGEMENT, MERCHANTABILITY, AND FITNESS FOR A PARTICULAR PURPOSE, OR WARRANTIES RELATED TO ITS CONDITION, QUALITY, OR PERFORMANCE.

IN NO EVENT WILL MICROCHIP BE LIABLE FOR ANY INDI-RECT, SPECIAL, PUNITIVE, INCIDENTAL, OR CONSE-QUENTIAL LOSS, DAMAGE, COST, OR EXPENSE OF ANY KIND WHATSOEVER RELATED TO THE INFORMATION OR ITS USE, HOWEVER CAUSED, EVEN IF MICROCHIP HAS BEEN ADVISED OF THE POSSIBILITY OR THE DAMAGES ARE FORESEEABLE. TO THE FULLEST EXTENT ALLOWED BY LAW, MICROCHIP'S TOTAL LIABILITY ON ALL CLAIMS IN ANY WAY RELATED TO THE INFORMATION OR ITS USE WILL NOT EXCEED THE AMOUNT OF FEES, IF ANY, THAT YOU HAVE PAID DIRECTLY TO MICROCHIP FOR THE INFORMATION.

Use of Microchip devices in life support and/or safety applications is entirely at the buyer's risk, and the buyer agrees to defend, indemnify and hold harmless Microchip from any and all damages, claims, suits, or expenses resulting from such use. No licenses are conveyed, implicitly or otherwise, under any Microchip intellectual property rights unless otherwise stated.

Trademarks

The Microchip name and logo, the Microchip logo, Adaptec, AVR, AVR logo, AVR Freaks, BesTime, BitCloud, CryptoMemory, CryptoRF, dsPIC, flexPWR, HELDO, IGLOO, JukeBlox, KeeLoq, Kleer, LANCheck, LinkMD, maXStylus, maXTouch, MediaLB, megaAVR, Microsemi, Microsemi logo, MOST, MOST logo, MPLAB, OptoLyzer, PIC, picoPower, PICSTART, PIC32 logo, PolarFire, Prochip Designer, QTouch, SAM-BA, SenGenuity, SpyNIC, SST, SST Logo, SuperFlash, Symmetricom, SyncServer, Tachyon, TimeSource, tinyAVR, UNI/O, Vectron, and XMEGA are registered trademarks of Microchip Technology Incorporated in the U.S.A. and other countries.

AgileSwitch, APT, ClockWorks, The Embedded Control Solutions Company, EtherSynch, Flashtec, Hyper Speed Control, HyperLight Load, Libero, motorBench, mTouch, Powermite 3, Precision Edge, ProASIC, ProASIC Plus, ProASIC Plus logo, Quiet- Wire, SmartFusion, SyncWorld, Temux, TimeCesium, TimeHub, TimePictra, TimeProvider, TrueTime, and ZL are registered trademarks of Microchip Technology Incorporated in the U.S.A.

Adjacent Key Suppression, AKS, Analog-for-the-Digital Age, Any Capacitor, AnyIn, AnyOut, Augmented Switching, BlueSky, BodyCom, Clockstudio, CodeGuard, CryptoAuthentication, CryptoAutomotive, CryptoCompanion, CryptoController, dsPICDEM, dsPICDEM.net, Dynamic Average Matching, DAM, ECAN, Espresso T1S, EtherGREEN, GridTime, IdealBridge, In-Circuit Serial Programming, ICSP, INICnet, Intelligent Paralleling, IntelliMOS, Inter-Chip Connectivity, JitterBlocker, Knob-on-Display, KoD, maxCrypto, maxView, memBrain, Mindi, MiWi, MPASM, MPF, MPLAB Certified logo, MPLIB, MPLINK, MultiTRAK, NetDetach, Omniscient Code Generation, PICDEM, PICDEM.net, PICkit, PICtail, PowerSmart, PureSilicon, QMatrix, REAL ICE, Ripple Blocker, RTAX, RTG4, SAM-ICE, Serial Quad I/O, simpleMAP, SimpliPHY, SmartBuffer, SmartHLS, SMART-I.S., storClad, SQI, SuperSwitcher, SuperSwitcher II, Switchtec, SynchroPHY, Total Endurance, Trusted Time, TSHARC, USBCheck, VariSense, VectorBlox, VeriPHY, ViewSpan, WiperLock, XpressConnect, and ZENA are trademarks of Microchip Technology Incorporated in the U.S.A. and other countries

SQTP is a service mark of Microchip Technology Incorporated in the U.S.A.

The Adaptec logo, Frequency on Demand, Silicon Storage Technology, and Symmcom are registered trademarks of Microchip Technology Inc. in other countries.

GestIC is a registered trademark of Microchip Technology Germany II GmbH & Co. KG, a subsidiary of Microchip Technology Inc., in other countries.

All other trademarks mentioned herein are property of their respective companies.

 $\ensuremath{\textcircled{\sc 0}}$ 2021 - 2023, Microchip Technology Incorporated and its subsidiaries.

All Rights Reserved.

ISBN: 978-1-6683-2448-6

For information regarding Microchip's Quality Management Systems, please visit www.microchip.com/quality.



Worldwide Sales and Service

AMERICAS

Corporate Office 2355 West Chandler Blvd. Chandler, AZ 85224-6199 Tel: 480-792-7200 Fax: 480-792-7277 Technical Support: http://www.microchip.com/ support

Web Address: www.microchip.com

Atlanta Duluth, GA Tel: 678-957-9614 Fax: 678-957-1455

Austin, TX Tel: 512-257-3370

Boston Westborough, MA Tel: 774-760-0087 Fax: 774-760-0088

Chicago Itasca, IL Tel: 630-285-0071 Fax: 630-285-0075

Dallas Addison, TX Tel: 972-818-7423 Fax: 972-818-2924

Detroit Novi, MI Tel: 248-848-4000

Houston, TX Tel: 281-894-5983

Indianapolis Noblesville, IN Tel: 317-773-8323 Fax: 317-773-5453 Tel: 317-536-2380

Los Angeles Mission Viejo, CA Tel: 949-462-9523 Fax 949-462-9608 Tel: 951-273-7800

Raleigh, NC Tel: 919-844-7510

New York NY Tel: 631-435-6000

San Jose, CA Tel: 408-735-9110 Tel: 408-436-4270

Canada - Toronto Tel: 905-695-1980 Fax: 905-695-2078

ASIA/PACIFIC

Australia - Sydney Tel: 61-2-9868-6733

China - Beijing Tel: 86-10-8569-7000 China - Chengdu

Tel: 86-28-8665-5511 China - Chongqing Tel: 86-23-8980-9588

China - Dongguan Tel: 86-769-8702-9880

China - Guangzhou Tel: 86-20-8755-8029

China - Hangzhou Tel: 86-571-8792-8115

China - Hong Kong SAR Tel: 852-2943-5100

China - Nanjing Tel: 86-25-8473-2460

China - Qingdao Tel: 86-532-8502-7355

China - Shanghai Tel: 86-21-3326-8000

China - Shenyang Tel: 86-24-2334-2829

China - Shenzhen Tel: 86-755-8864-2200

China - Suzhou Tel: 86-186-6233-1526

China - Wuhan Tel: 86-27-5980-5300

China - Xian Tel: 86-29-8833-7252

China - Xiamen Tel: 86-592-2388138 China - Zhuhai

Tel: 86-756-3210040

ASIA/PACIFIC

India - Bangalore Tel: 91-80-3090-4444

India - New Delhi Tel: 91-11-4160-8631 India - Pune

Tel: 91-20-4121-0141 Japan - Osaka

Tel: 81-6-6152-7160

Japan - Tokyo Tel: 81-3-6880- 3770 Korea - Daegu

Tel: 82-53-744-4301 Korea - Seoul

Tel: 82-2-554-7200

Malaysia - Kuala Lumpur Tel: 60-3-7651-7906

Malaysia - Penang Tel: 60-4-227-8870

Philippines - Manila Tel: 63-2-634-9065

Singapore Tel: 65-6334-8870

Taiwan - Hsin Chu

Tel: 886-3-577-8366 Taiwan - Kaohsiung Tel: 886-7-213-7830

Taiwan - Taipei Tel: 886-2-2508-8600

Thailand - Bangkok Tel: 66-2-694-1351

Vietnam - Ho Chi Minh Tel: 84-28-5448-2100

Tel: 31-416-690399 Fax: 31-416-690340

Norway - Trondheim

Spain - Madrid Tel: 34-91-708-08-90 Fax: 34-91-708-08-91

Sweden - Gothenberg

Sweden - Stockholm Tel: 46-8-5090-4654

UK - Wokingham Tel: 44-118-921-5800 Fax: 44-118-921-5820

France - Paris Tel: 33-1-69-53-63-20 Fax: 33-1-69-30-90-79

> Germany - Garching Tel: 49-8931-9700 Germany - Haan

EUROPE

Austria - Wels

Tel: 43-7242-2244-39

Tel: 45-4485-5910

Fax: 45-4485-2829

Tel: 358-9-4520-820

Finland - Espoo

Fax: 43-7242-2244-393

Denmark - Copenhagen

Tel: 49-2129-3766400 Germany - Heilbronn

Tel: 49-7131-72400

Germany - Karlsruhe Tel: 49-721-625370

Germany - Munich Tel: 49-89-627-144-0 Fax: 49-89-627-144-44

Germany - Rosenheim Tel: 49-8031-354-560

Israel - Ra'anana Tel: 972-9-744-7705

Italy - Milan Tel: 39-0331-742611 Fax: 39-0331-466781

Italy - Padova Tel: 39-049-7625286

Netherlands - Drunen

Tel: 47-7288-4388

Poland - Warsaw Tel: 48-22-3325737

Romania - Bucharest Tel: 40-21-407-87-50

Tel: 46-31-704-60-40